# PHOTON IS OUR BUSINESS



## **CCD** area image sensor

S13240/S13241 series S10140/S10141 series (-01)

# Low readout noise, high resolution (pixel size: 12 µm)

The S13240/S13241 series and S10140/S10141 series (-01) are back-thinned FFT-CCD area image sensors developed for low-light-level detection. By using the binning operation, they can be used as a linear image sensor having a vertically long photosensitive area. This makes them suited for use in spectrophotometry. The binning operation offers significant improvement in S/N and signal processing speed compared with conventional methods by which signals are digitally added by an external circuit. These products feature low noise and low dark current (MPP mode operation). This allows low-light-level detection by making the integration time longer. And, wide dynamic range has been achieved by increasing the saturation charge than that of the previous product (S10140/S10141 series).

The S13240/S13241 series is a high-speed readout type, and the S10140/S10141 series (-01) is a low noise type. These products have an pixel size of  $12 \times 12 \, \mu m$  and are available in the photosensitive area ranging from 24.576 (H)  $\times$  1.464 (V) mm<sup>2</sup> (2048  $\times$  122 pixels) to 24.576 (H)  $\times$  6.072 (V) mm<sup>2</sup> (2048  $\times$  506 pixels).

#### **Features**

- **■** Wide dynamic range
- **Low readout noise:** 4 e rms typ. [S10140/S10141 series (-01)]
  - 30 e<sup>-</sup> rms typ. (S13240/S13241 series)
- High resolution: pixel size 12 x 12 μm
- Non-cooled type: S13240 series, S10140 series (-01)
  One-stage TE-cooled type: S13241 series, S10141 series (-01)
- Quantum efficiency: 90% or higher at peak
- Wide spectral response range
- **■** MPP operation
- High UV sensitivity and stable characteristics under UV light irradiation
- Pin compatible with the S7030/S7031 series [S10140/S10141 series (-01)]

#### Applications

- → Fluorescence spectrophotometry, ICP
- Industrial product inspection
- **⇒** Semiconductor inspection
- **DNA** sequencer
- **Low-light-level detection**
- Raman spectroscopy

#### **Selection guide**

| Type no.        | Cooling             | Readout speed<br>max.<br>(MHz) | Total number of pixels (H) × (V) | Number of effective pixels (H) × (V) | Image size<br>mm (H) × mm (V) | Suitable<br>multichannel<br>detector head |
|-----------------|---------------------|--------------------------------|----------------------------------|--------------------------------------|-------------------------------|---|
| S13240-1107     |                     |                                | 2068 × 128                       | 2048 × 122                           | 24.576 × 1.464                |   |
| S13240-1108     | Non-cooled          | 10                             | 2068 × 256                       | 2048 × 250                           | 24.576 × 3.000                | -   |
| S13240-1109     |                     |                                | 2068 × 512                       | 2048 × 506                           | 24.576 × 6.072                |   |
| S13241-1107S    |                     |                                | 2068 × 128                       | 2048 × 122                           | 24.576 × 1.464                |   |
| S13241-1108S    | One-stage TE-cooled | 10                             | 2068 × 256                       | 2048 × 250                           | 24.576 × 3.000                | -   |
| S13241-1109S    |                     |                                | 2068 × 512                       | 2048 × 506                           | 24.576 × 6.072                |   |
| S10140-1107-01  |                     |                                | 2068 × 128                       | 2048 × 122                           | 24.576 × 1.464                |   |
| S10140-1108-01  | Non-cooled          | 0.5                            | 2068 × 256                       | 2048 × 250                           | 24.576 × 3.000                | C10150-01                                 |
| S10140-1109-01  |                     |                                | 2068 × 512                       | 2048 × 506                           | 24.576 × 6.072                |   |
| S10141-1107S-01 |                     |                                | 2068 × 128                       | 2048 × 122                           | 24.576 × 1.464                |   |
| S10141-1108S-01 | One-stage TE-cooled | 0.5                            | 2068 × 256                       | 2048 × 250                           | 24.576 × 3.000                | C10151-01                                 |
| S10141-1109S-01 |                     |                                | 2068 × 512                       | 2048 × 506                           | 24.576 × 6.072                |   |

Note: S10142 series (-01) [Two-stage TE-cooled type] is available upon request (made-to-order products).

#### Structure

| Parameter          | S13240 series      | S13241 series        | S10140 series (-01) | S10141 series (-01)  |  |  |  |
|--------------------|--------------------|----------------------|---------------------|----------------------|--|--|--|
| Pixel size (H × V) | 12 × 12 μm         |                      |                     |                      |  |  |  |
| Vertical clock     | 2-phase            |                      |                     |                      |  |  |  |
| Horizontal clock   | 2-phase            |                      |                     |                      |  |  |  |
| Output circuit     | Two-stage MOSF     | ET source follower   | One-stage MOSFI     | ET source follower   |  |  |  |
| Package            | 24-pin ceramic DIP |                      |                     |                      |  |  |  |
| Window material*1  | Quartz glass*2     | AR-coated sapphire*3 | Quartz glass*2      | AR-coated sapphire*3 |  |  |  |

<sup>\*1:</sup> Temporary window type (ex. S13240-1107N) can also be provided.

#### **♣** Absolute maximum ratings (Ta=25 °C)

| Para                                    | meter                         | Symbol       | Min. | Тур. | Max. | Unit |
|---|-------------------------------|--------------|------|------|------|------|
| Operating tempera                       | iture*4                       | Topr         | -50  | -    | +50  | °C   |
| Storage temperatu                       | ire                           | Tstg         | -50  | -    | +70  | °C   |
| Output transistor                       | S13240/S13241<br>series       | Vod          | -0.5 | -    | +20  | V    |
| drain voltage                           | S10140/S10141<br>series (-01) | VOD          | -0.5 | -    | +25  | V    |
| Reset drain voltage                     | 9                             | <b>V</b> RD  | -0.5 | -    | +18  | V    |
| Output amplifier return voltage         | S13240/S13241<br>series       | Vret         | -0.5 | -    | +18  | V    |
| Horizontal input source voltage         |                               | VISH         | -0.5 | -    | +18  | V    |
| Vertical input gate voltage             |                               | VIG1V, VIG2V | -11  | -    | +15  | V    |
| Horizontal input gate voltage           |                               | VIG1H, VIG2H | -11  | -    | +15  | V    |
| Summing gate volt                       | tage                          | Vsg          | -11  | -    | +15  | V    |
| Output gate voltag                      | je                            | Vog          | -11  | -    | +15  | V    |
| Reset gate voltage                      | <b>!</b>                      | Vrg          | -11  | -    | +15  | V    |
| Transfer gate volta                     | ige                           | VTG          | -11  | -    | +15  | V    |
| Vertical shift regist                   | er clock voltage              | VP1V, VP2V   | -11  | -    | +15  | V    |
| Horizontal shift register clock voltage |                               | VP1H, VP2H   | -11  | -    | +15  | V    |
| Maximum current of built-in TE-cooler*5 |                               | Imax         | -    | -    | 3.0  | Α    |
| Maximum voltage                         | of built-in TE-cooler         | Vmax         | -    | -    | 3.6  | V    |
| Maximum tempera radiation side          | ture of heat                  | -            | -    | -    | 70   | °C   |

Note: Exceeding the absolute maximum ratings even momentarily may cause a drop in product quality. Always be sure to use the product within the absolute maximum ratings.



<sup>\*2:</sup> Resin sealing

<sup>\*3:</sup> Hermetic sealing

<sup>\*4:</sup> Package temperature [S13240 series, S10140 series (-01)], chip temperature [S13241 series, S10141 series (-01)]

<sup>\*5:</sup> When the current value exceeds Imax, the heat absorption begins to decrease due to the Joule heat. This maximum current Imax is not the threshold for damaging the thermoelectric cooler. To protect the thermoelectric cooler and maintain stable operation, the supply current should be less than 60% of this maximum current.

#### **□** Operating conditions (MPP mode, Ta=25 °C)

| Paramet                        | Parameter          |       | Symbol       | S1324 | 10/S13241 | series | S10140/ | S10141 ser | ries (-01) | Linit                                 |  |
|--------------------------------|--------------------|-------|--------------|-------|-----------|--------|---------|------------|------------|---------------------------------------|--|
| Parameu                        | EI                 |       | Зуппрог      | Min.  | Тур.      | Max.   | Min.    | Тур.       | Max.       | V V V V V V V V V V V V V V V V V V V |  |
| Output transistor drain ve     | oltage             |       | Vod          | 14    | 16        | 18     | 20      | 22         | 24         | V                                     |  |
| Reset drain voltage            |                    |       | Vrd          | 15    | 16        | 17     | 14      | 15         | 16         | V                                     |  |
| Output gate voltage            |                    |       | Vog          | 3     | 5         | 7      | 3       | 5          | 7          | V                                     |  |
| Substrate voltage              |                    |       | Vss          | -     | 0         | -      | -       | 0          | -          | V                                     |  |
| Output amplifier return v      | oltage*6           |       | Vret         | -     | 4         | 5      |         |            |            | V                                     |  |
|                                | Input source       | æ     | VISH         | -     | Vrd       | -      | -       | Vrd        | -          |                                       |  |
| Test point                     | Vertical i<br>gate | input | VIG1V, VIG2V | -10   | -9        | -      | -10     | -9         | -          | ٧                                     |  |
| ·                              | Horizontal gate    | input | VIG1H, VIG2H | -10   | -9        | -      | -10     | -9         | -          |                                       |  |
| Vertical shift register cloc   | sk voltago         | High  | VP1VH, VP2VH | 1     | 3         | 5      | 1       | 3          | 5          | V                                     |  |
| vertical stillt register cloc  | LK VOILage         | Low   | VP1VL, VP2VL | -10   | -9        | -8     | -10     | -9         | -8         | v                                     |  |
| Horizontal shift register of   | lock voltage       | High  | VP1HH, VP2HH | 5     | 7         | 9      | 5       | 7          | 9          | V                                     |  |
| Tiorizoritai sriirt register c | lock voitage       | Low   | VP1HL, VP2HL | -9    | -7        | -5     | -9      | -7         | -5         | v                                     |  |
| Summing gate voltage           |                    | High  | Vsgh         | 5     | 7         | 9      | 5       | 7          | 9          | V                                     |  |
| Summing gate voltage           |                    | Low   | Vsgl         | -9    | -7        | -5     | -9      | -7         | -5         |                                       |  |
| Reset gate voltage             |                    | High  | Vrgh         | 8     | 9         | 10     | 8       | 9          | 10         | V                                     |  |
|                                |                    | Low   | VRGL         | -6    | -5        | -4     | -6      | -5         | -4         | v                                     |  |
| Transfer gate voltage High     |                    | High  | VTGH         | 1     | 3         | 5      | 1       | 3          | 5          | V                                     |  |
|                                |                    | Low   | VTGL         | -10   | -9        | -8     | -10     | -9         | -8         | v                                     |  |
| External load resistance       |                    |       | RL           | 2.0   | 2.2       | 2.4    | 20      | 22         | 24         | kΩ                                    |  |

<sup>\*6:</sup> Output amplifier return voltage is a positive voltage with respect to substrate voltage, but the current flows out from the sensor.

#### **►** Electrical characteristics (Ta=25 °C)

| Paramete                              |                  | Cymhal     | S1324   | 10/S13241 | series | S10140/ | S10141 ser | ries (-01) | Unit |
|---------------------------------------|------------------|------------|---------|-----------|--------|---------|------------|------------|------|
| Paramete                              | Symbol Min. Typ. |            | Max.    | Min.      | Тур.   | Max.    | Offic      |            |      |
| Output signal frequency*              | 7                | fc         | -       | 2.5       | 10     | -       | 0.25       | 0.5        | MHz  |
| Vautiant abiffunction                 | -1107 (-01)      |            | -       | 1600      | -      | -       | 1600       | -          |      |
| Vertical shift register capacitance   | -1108 (-01)      | CP1W, CP2W | -       | 3200      | -      | -       | 3200       | -          | pF   |
| сараспапсе                            | -1109 (-01)      |            | -       | 6400      | -      | -       | 6400       | -          |      |
| Horizontal shift register capacitance |                  | Ср1н, Ср2н | -       | 150       | -      | -       | 150        | -          | pF   |
| Summing gate capacitance              |                  | Csg        | -       | 30        | -      | -       | 30         | -          | pF   |
| Reset gate capacitance                |                  | CRG        | -       | 30        | -      | -       | 30         | -          | pF   |
| Transfer gate capacitance             | 2                | Стб        | -       | 70        | -      | -       | 70         | -          | pF   |
| Charge transfer efficiency*8          |                  | CTE        | 0.99995 | 0.99999   | -      | 0.99995 | 0.99999    | -          | -    |
| DC output level*7                     |                  | Vout       | 10      | 11        | 12     | 16      | 17         | 18         | V    |
| Output impedance*7                    |                  | Zo         | -       | 0.2       | -      | -       | 5          | -          | kΩ   |
| Output amplifier return current*9     |                  | Iret       | -       | 0.4       | -      | -       | -          | -          | mA   |
| Power consumption*7 *10               |                  | Р          | -       | 100       | -      | -       | 16         | -          | mW   |

<sup>\*7:</sup> The values depend on the load resistance (S13240/S13241 series: VoD=16 V, RL=2.2 k $\Omega$ , S10140/S10141 series (-01): VoD=22 V, RL=22 k $\Omega$ )



<sup>\*8:</sup> Charge transfer efficiency per pixel, measured at half of the saturation output

<sup>\*9:</sup> Absolute value

The current flows in the direction of flow out of the sensor.

<sup>\*10:</sup> Power consumption of the on-chip amp plus load resistance

#### **■** Electrical and optical characteristics (Ta=25 °C, unless otherwise noted)

| n                              | Parameter                   |          | S132 | 40/S13241   | series | S10140/ | S10141 ser  | ies (-01) | Unit                    |
|--------------------------------|-----------------------------|----------|------|-------------|--------|---------|-------------|-----------|-------------------------|
| r                              | arameter                    | Symbol   | Min. | Тур.        | Max.   | Min.    | Тур.        | Max.      | Offic                   |
| Saturation output vo           | tage                        | Vsat     | -    | Fw × CE     | -      | -       | Fw × CE     | -         | V                       |
|                                | Vertical                    |          | 60   | 70          | -      | 60      | 70          | -         |                         |
| Full well capacity             | Horizontal                  | Fw       | 400  | 500         | -      | 400     | 500         | -         | ke⁻                     |
|                                | Summing                     |          | 400  | 500         | -      | 400     | 500         | -         |                         |
| Conversion efficiency          |                             | CE       | 4.5  | 5.5         | 6.5    | 4       | 5           | 6         | μV/e <sup>-</sup>       |
| Dark current*11                | 25 °C                       | 25 °C DS |      | 30          | 300    | -       | 30          | 300       | e <sup>-</sup> /pixel/s |
| (MPP mode)                     | (MPP mode) 0 °C             |          | -    | 3           | 30     | -       | 3           | 30        | e /pixei/s              |
| Readout noise*12               | Readout noise*12            |          | -    | 30          | 45     | -       | 4           | 18        | e- rms                  |
| Dynamic range*13               | Line binning                | - Drange | 8888 | 16666       | -      | 22222   | 125000      | -         | -                       |
| Dynamic range                  | Area scanning               | Drange   | 1333 | 2333        | -      | 3333    | 20000       | -         | -                       |
| Spectral response ra           | nge                         | λ        |      | 200 to 1100 | )      | 2       | 200 to 1100 | )         | nm                      |
| Photoresponse nonuniformity*14 |                             | PRNU     | -    | ±3          | ±10    | -       | ±3          | ±10       | %                       |
|                                | Point defect*15 White spots |          | -    | -           | 0      | -       | -           | 0         | -                       |
| Blemish                        | Black spots                 | ]        | -    | -           | 10     | -       | -           | 10        | -                       |
| DICHIISH                       | Cluster defect*16           | ] -      | -    | -           | 3      | -       | -           | 3         | -                       |
|                                | Column defect*17            |          | -    | -           | 0      | -       | -           | 0         | -                       |

<sup>\*11:</sup> Dark current nearly doubles for every 5 to 7 °C increase in temperature.

Photoresponse nonuniformity =  $\frac{\text{Fixed pattern noise (peak to peak)}}{\text{Signal}} \times 100 \, [\%]$ 

Pixels whose dark current is higher than 1 ke $^{\circ}$  after one-second integration at a cooling temperature of 0  $^{\circ}$ C Black spots

Pixels whose sensitivity is lower than one half of the average pixel output (measured with uniform light producing one-half of the saturation charge)



<sup>\*12:</sup> Operating frequency 20 kHz, temperature -50 °C [S10140/S10141 series (-01)] Operating frequency 2.5 MHz, temperature 0 °C (S13240/S13241 series)

<sup>\*13:</sup> Dynamic range=Saturation charge/Readout noise

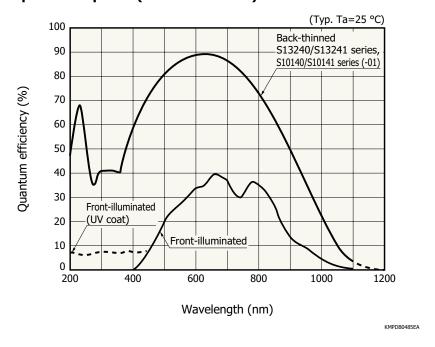
<sup>\*14:</sup> Measured at one-half of the saturation output using LED light (peak emission wavelength: 470 nm)

<sup>\*15:</sup> White spots

<sup>\*16: 2</sup> to 9 consecutive image defects

<sup>\*17: 10</sup> or more consecutive image defects

#### **►** Spectral response (without window)\*18

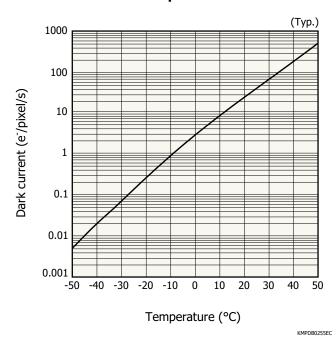


\*18: Spectral response with quartz glass or AR-coated sapphire are decreased according to the spectral transmittance characteristics of window material.

#### Spectral transmittance characteristics

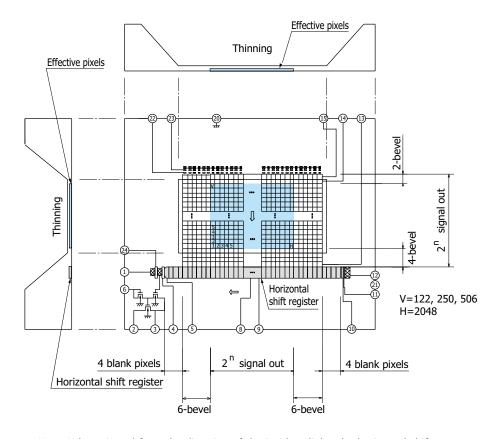
### (Typ. Ta=25 °C) 100 90 80 Quartz glass window 70 Transmittance (%) AR-coated sapphire 60 50 40 30 20 10 100 200 300 400 500 600 700 800 900 1000 1100 1200 Wavelength (nm) KMPDR0110FA

#### - Dark current vs. temperature



#### Device structure (schematic of CCD chip as viewed from top of dimensional outline)

S13240/S13241 series

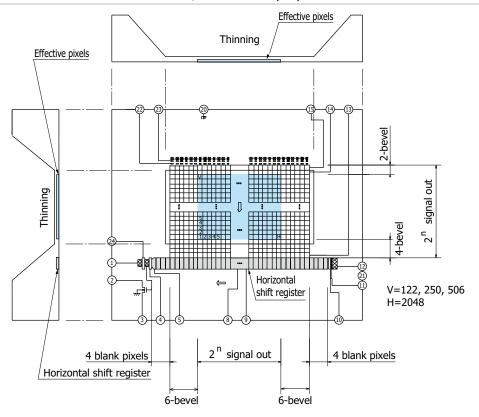


Note: When viewed from the direction of the incident light, the horizontal shift register is covered with a thick silicon layer (dead layer). However, long-wavelength light passes through the silicon dead layer and may possibly be detected by the horizontal shift register. To prevent this, provide light shield on that area as needed.

KMPDC0612EA



#### S10140/S10141 series (-01)

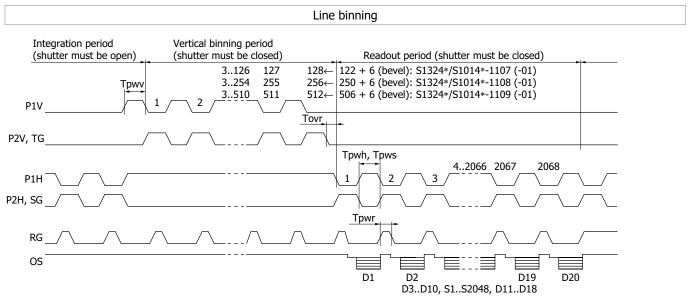


Note: When viewed from the direction of the incident light, the horizontal shift register is covered with a thick silicon layer (dead layer). However, long-wavelength light passes through the silicon dead layer and may possibly be detected by the horizontal shift register. To prevent this, provide light shield on that area as needed.

KMPDC0613EA



#### **Timing chart**



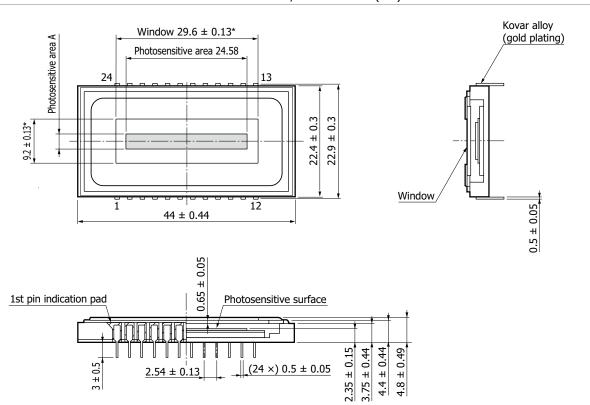
KMPDC0614EA

| Day             | rameter        |             | Symbol     | S1324 | 10/S13241 | series | S10140/ | S10141 sei | ries (-01) | Unit  |
|-----------------|----------------|-------------|------------|-------|-----------|--------|---------|------------|------------|-------|
| Pal             | i didiletti    |             | Symbol     | Min.  | Тур.      | Max.   | Min.    | Тур.       | Max.       | Ullit |
|                 | Dulas          | -1107 (-01) |            | 0.75  | 1         | -      | 3       | 4          | -          |       |
| P1V, P2V, TG*19 | Pulse<br>width | -1108 (-01) | Tpwv       | 1.5   | 2         | -      | 6       | 8          | -          | μs    |
| P1V, P2V, 1G*15 | Widti          | -1109 (-01) |            | 3     | 4         | -      | 12      | 16         | -          |       |
|                 | Rise and       | fall times  | Tprv, Tpfv | 20    | -         | -      | 20      | -          | -          | ns    |
|                 | Pulse width    |             | Tpwh       | 50    | 200       | -      | 1000    | 2000       | -          | ns    |
| P1H, P2H*19     | Rise and       | fall times  | Tprh, Tpfh | 10    | -         | -      | 10      | -          | -          | ns    |
|                 | Duty ratio     | )           | -          | 40    | 50        | 60     | 40      | 50         | 60         | %     |
|                 | Pulse wid      | lth         | Tpws       | 50    | 200       | -      | 1000    | 2000       | -          | ns    |
| SG              | Rise and       | fall times  | Tprs, Tpfs | 10    | -         | -      | 10      | -          | -          | ns    |
|                 | Duty ratio     |             | -          | 40    | 50        | 60     | 40      | 50         | 60         | %     |
| D.C.            | Pulse width    |             | Tpwr       | 10    | 40        | -      | 100     | 1000       | -          | ns    |
| RG              | Rise and       | fall times  | Tprr, Tpfr | 5     | -         | -      | 5       | -          | -          | ns    |
| TG – P1H        | Overlap t      | ime         | Tovr       | 1     | 2         | -      | 1       | 2          | -          | μs    |

 $<sup>^{\</sup>star}$ 19: Symmetrical clock pulses should be overlapped at 50% of maximum pulse amplitude.

#### Dimensional outline (unit: mm)

#### S13240 series, S10140 series (-01)

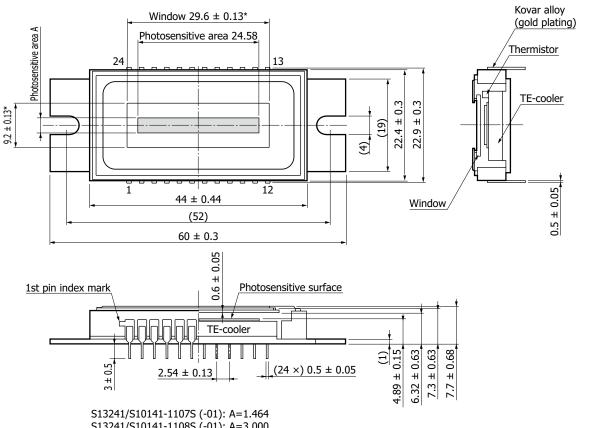


S13240/S10140-1107 (-01): A=1.464 S13240/S10140-1108 (-01): A=3.000 S13240/S10140-1109 (-01): A=6.072

KMPDA0567EB

<sup>\*</sup> Size of window that guarantees the transmittance in the "Spectral transmittance characteristics" graph is 28.6  $\times$  8.2 mm. weight: 11.9 g

#### S13241 series, S10141 series (-01)



S13241/S10141-1107S (-01): A=1.464 S13241/S10141-1108S (-01): A=3.000 S13241/S10141-1109S (-01): A=6.072

KMPDA0358EB

<sup>\*</sup> Size of window that guarantees the transmittance in the "Spectral transmittance characteristics" graph is  $27.6 \times 7.2 \text{ mm}$ . Weight: 38.7 g

#### **₽** Pin connections

| Pin |        | S13240 series                        |        | S13241 series                        | Remark               |
|-----|--------|--------------------------------------|--------|--------------------------------------|----------------------|
| No. | Symbol | Function                             | Symbol | Function                             | (standard operation) |
| 1   | RD     | Reset drain                          | RD     | Reset drain                          | +16 V                |
| 2   | OS     | Output transistor source             | OS     | Output transistor source             | RL=2.2 kΩ            |
| 3   | OD     | Output transistor drain              | OD     | Output transistor drain              | +16 V                |
| 4   | OG     | Output gate                          | OG     | Output gate                          | +5 V                 |
| 5   | SG     | Summing gate                         | SG     | Summing gate                         | Same timing as P2H   |
| 6   | Vret   | Output amplifier return              | Vret   | Output amplifier return              | +4 V                 |
| 7   | -      |                                      | -      |                                      |                      |
| 8   | P2H    | CCD horizontal register clock-2      | P2H    | CCD horizontal register clock-2      |                      |
| 9   | P1H    | CCD horizontal register clock-1      | P1H    | CCD horizontal register clock-1      |                      |
| 10  | IG2H   | Test point (horizontal input gate-2) | IG2H   | Test point (horizontal input gate-2) | -9 V                 |
| 11  | IG1H   | Test point (horizontal input gate-1) | IG1H   | Test point (horizontal input gate-1) | -9 V                 |
| 12  | ISH    | Test point (horizontal input source) | ISH    | Test point (horizontal input source) | Connect to RD        |
| 13  | TG*20  | Transfer gate                        | TG*20  | Transfer gate                        | Same timing as P2V   |
| 14  | P2V    | CCD vertical register clock-2        | P2V    | CCD vertical register clock-2        |                      |
| 15  | P1V    | CCD vertical register clock-1        | P1V    | CCD vertical register clock-1        |                      |
| 16  | -      |                                      | Th1    | Thermistor                           |                      |
| 17  | -      |                                      | Th2    | Thermistor                           |                      |
| 18  | -      |                                      | P-     | TE-cooler (-)                        |                      |
| 19  | -      |                                      | P+     | TE-cooler (+)                        |                      |
| 20  | SS     | Substrate (GND)                      | SS     | Substrate (GND)                      | GND                  |
| 21  | RD     | Reset drain                          | RD     | Reset drain                          | +16 V                |
| 22  | IG2V   | Test point (vertical input gate-2)   | IG2V   | Test point (vertical input gate-2)   | -9 V                 |
| 23  | IG1V   | Test point (vertical input gate-1)   | IG1V   | Test point (vertical input gate-1)   | -9 V                 |
| 24  | RG     | Reset gate                           | RG     | Reset gate                           |                      |

<sup>\*20:</sup> Isolation gate between vertical register and horizontal register. In standard operation, TG should be applied the same pulse as P2V.

| Pin |        | S10140 series (-01)                  |                   | S10141 series (-01)                  | Remark               |
|-----|--------|--------------------------------------|-------------------|--------------------------------------|----------------------|
| No. | Symbol | Function                             | Symbol            | Function                             | (standard operation) |
| 1   | RD     | Reset drain                          | RD                | Reset drain                          | +15 V                |
| 2   | OS     | Output transistor source             | OS                | Output transistor source             | RL=22 kΩ             |
| 3   | OD     | Output transistor drain              | OD                | Output transistor drain              | +22 V                |
| 4   | OG     | Output gate                          | OG                | Output gate                          | +5 V                 |
| 5   | SG     | Summing gate                         | SG                | Summing gate                         | Same timing as P2H   |
| 6   | -      |                                      | -                 |                                      |                      |
| 7   | -      |                                      | -                 |                                      |                      |
| 8   | P2H    | CCD horizontal register clock-2      | P2H               | CCD horizontal register clock-2      |                      |
| 9   | P1H    | CCD horizontal register clock-1      | P1H               | CCD horizontal register clock-1      |                      |
| 10  | IG2H   | Test point (horizontal input gate-2) | IG2H              | Test point (horizontal input gate-2) | -9 V                 |
| 11  | IG1H   | Test point (horizontal input gate-1) | IG1H              | Test point (horizontal input gate-1) | -9 V                 |
| 12  | ISH    | Test point (horizontal input source) | ISH               | Test point (horizontal input source) | Connect to RD        |
| 13  | TG*21  | Transfer gate                        | TG* <sup>21</sup> | Transfer gate                        | Same timing as P2V   |
| 14  | P2V    | CCD vertical register clock-2        | P2V               | CCD vertical register clock-2        |                      |
| 15  | P1V    | CCD vertical register clock-1        | P1V               | CCD vertical register clock-1        |                      |
| 16  | -      |                                      | Th1               | Thermistor                           |                      |
| 17  | -      |                                      | Th2               | Thermistor                           |                      |
| 18  | -      |                                      | P-                | TE-cooler (-)                        |                      |
| 19  | -      |                                      | P+                | TE-cooler (+)                        |                      |
| 20  | SS     | Substrate (GND)                      | SS                | Substrate (GND)                      | GND                  |
| 21  | RD     | Reset drain                          | RD                | Reset drain                          | +15 V                |
| 22  | IG2V   | Test point (vertical input gate-2)   | IG2V              | Test point (vertical input gate-2)   | -9 V                 |
| 23  | IG1V   | Test point (vertical input gate-1)   | IG1V              | Test point (vertical input gate-1)   | -9 V                 |
| 24  | RG     | Reset gate                           | RG                | Reset gate                           |                      |

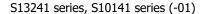
<sup>\*21:</sup> Isolation gate between vertical register and horizontal register. In standard operation, TG should be applied the same pulse as P2V.

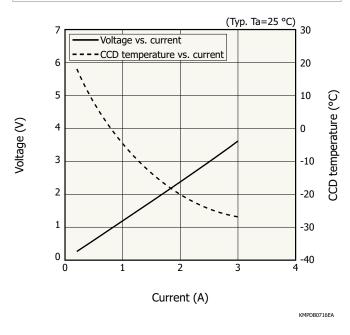


#### Specifications of built-in TE-cooler (Typ.)

| Parameter                  | Symbol | Condition | S13241 series, S10141 series (-01) | Unit |
|----------------------------|--------|-----------|------------------------------------|------|
| Internal resistance        | Rint   | Ta=25 °C  | 1.2                                | Ω    |
| Maximum heat absorption*22 | Qmax   |           | 5.1                                | W    |

<sup>\*22:</sup> This is a theoretical heat absorption level for correcting the temperature difference that occurs in the thermoelectric cooler when the maximum current is supplied.





To make the cooling side -10 °C, the temperature on the heat radiation side must be 30 °C or less. As a guideline, use a heatsink whose thermal resistance is no more than 1 °C /W.

#### Specifications of built-in temperature sensor

A thermistor chip is built into the same package with a CCD chip and monitors the operating CCD chip temperature. The relation between this thermistor's resistance and absolute temperature is express by the following equation.

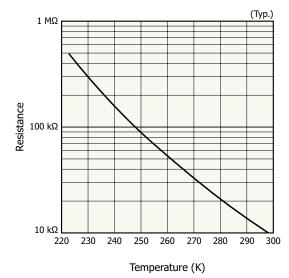
 $RT1 = RT2 \times exp BT1/T2 (1/T1 - 1/T2)$ 

RT1: resistance at absolute temperature T1 [K] RT2: resistance at absolute temperature T2 [K]

BT1/T2: B constant [K]

The characteristics of the thermistor used are as follows.

R298=10 k $\Omega$ B298/323=3450 K



KMPDB0111EB



#### Precautions (electrostatic countermeasures)

- · Handle these sensors with bare hands or wearing cotton gloves. In addition, wear anti-static clothing or use a wrist band with an earth ring, in order to prevent electrostatic damage due to electrical charges from friction.
- · Do not place the sensor directly on workbenches or floors that may become charged with static electricity.
- · Connect a ground wire to workbenches or floors in order to discharge static electricity.
- · Ground tools, such as tweezers and soldering irons, that are used to handle the sensor.

It is not always necessary to provide all the electrostatic countermeasures stated above. Implement these countermeasures according to the extent of deterioration or damage that may occur.

#### Temperature gradient rate for cooling or heating of element

When using an external cooler, set the temperature gradient rate for cooling or heating the element to 5 K/minute or less.

#### Recommended soldering conditions

| Parameter             | Specification                        | Note                               |
|-----------------------|--------------------------------------|------------------------------------|
| Soldering temperature | 260 °C max. (once, within 5 seconds) | At least 2 mm away from lead roots |

#### Related information

www.hamamatsu.com/sp/ssd/doc\_en.html

- Precautions
- Disclaimer
- · Image sensors
- Technical note
- · CCD image sensors

#### Multichannel detector heads C10150-01, C10151-01 [for S10140/S10141 series(-01)]

The C10150-01 is a multichannel detector head designed for non-cooled type S10140 series (-01) and the C10151-01 is for one-stage TE-cooled type S10141 series (-01). They incorporate a low-noise driver circuit that provides reliable operation by supplying external start and CLK signals.

#### Features

- Line binning operation/area scanning operation
- → Highly stable temperature controller (C10151-01) Cooling temperature: Tchip=-10 ± 0.05 °C
- Simple operation by supplying two types of signals





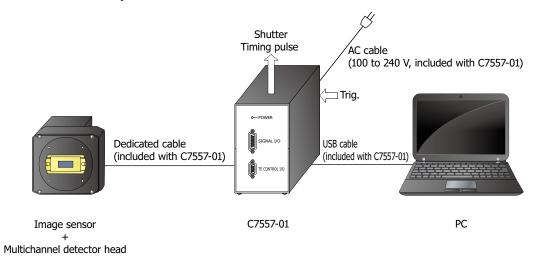
#### Multichannel detector head controller C7557-01

#### Features

- For control of multichannel detector head and data acquisition
- Easy control and data acquisition using supplied software via USB interface



#### Connection example



Note: Shutter, etc. are not available.

Information described in this material is current as of October 2023.

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## MAMATSU

www.hamamatsu.com

HAMAMATSU PHOTONICS K.K., Solid State Division

1126-1 Ichino-cho, Higashi-ku, Hamamatsu City, 435-8558 Japan, Telephone: (81)53-434-3311, Fax: (81)53-434-5184

ILIZO-1 ICRIINO-CRO, HIGBSRI-KU, Hamamatsu City, 435-8558 Japan, Telephone: (1)908-231-0960, Fax: (1)908-231-1218

Germany: HAMAMATSU CORPORATION: 360 Foothill Road, Bridgewater, NJ 08807, U.S.A., Telephone: (1)908-231-0960, Fax: (1)908-231-1218

Germany: HAMAMATSU PHOTONICS DEUTSCHLAND GMBH: Arzbergerstr. 10, 82211 Herrsching am Ammersee, Germany, Telephone: (49)8152-375-0, Fax: (49)8152-265-8 E-mail: info@hamamatsu.de

France: HAMAMATSU PHOTONICS FRANCE S.A.R.L.: 19 Rue du Saule Trapu, Parc du Moulin de Massy, 91882 Massy Cedex, France; Telephone: (33)1 69 53 71 00, Fax: (33)1 69 53 71 10 E-mail: info@hamamatsu.df

United Kingdom: HAMAMATSU PHOTONICS UK LIMITED: 2 Howard Court, 10 Tewin Road, Welwyn Garden City, Hertfordshire, AL7 18W, UK, Telephone: (44)1707-2925777 E-mail: info@hamamatsu.co.uk

North Europe: HAMAMATSU PHOTONICS NORDEN AB: Torshamnsgatan 35, 16440 Kista, Sweden, Telephone: (46)8-509-031-00, Fax: (46)8-509-031-01 E-mail: info@hamamatsu.de

Taly: HAMAMATSU PHOTONICS (TAILA S.R.L.: Strada della Moia, 1 int. 6 20044 Arese (Milano), Italy, Telephone: (46)8-509-031-01 E-mail: info@hamamatsu.it

China: HAMAMATSU PHOTONICS (CHINA) CO., LTD.: 1201, Tower B, Jianning Center, 27 Dongsanhuan Bellu, Chaoyang District, 100020 Beijing, PR. China, Telephone: (86)10-6586-606, Fax: (86)10-6586-606